

**Search Notes**

Application/Control No.

10/651,524

Examiner

Gopal C. Ray

Applicant(s)/Patent under  
Reexamination

DENG ET AL.

Art Unit

2111

**SEARCHED**

Class	Subclass	Date	Examiner
710	306,315,1 00,313,52, 305,5,33	7/21/2005	GCR
712	32	7/21/2005	GCR
709	253	7/21/2005	GCR
710	57,260	7/22/2005	GCR
710	63,72	7/22/2005	GCR
711	111-112	7/22/2005	GCR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
710	306,315	7/22/2005	GCR
710	100,313	7/22/2005	GCR
710	52,305,5	7/22/2005	GCR
710/33,57,63,72,260;712 /32;709/253;711/111-112		7/22/2005	GCR

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB	7/21/2005	GCR
EAST: USPT	7/21/2005	GCR
NPL; IEEE Xplore	7/21/2005	GCR